# International Rectifier

# IRF9Z24NPbF

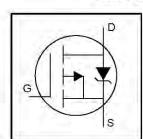
HEXFET® Power MOSFET

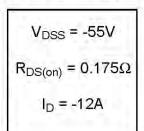
- Lead-Free
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated

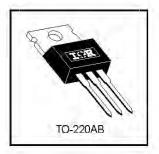
#### Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.







#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, VGS @ -10V	-12	A
ID @ TC = 100°C	Continuous Drain Current, VGS @ -10V	-8.5	
loм	Pulsed Drain Current ①	-48	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
EAS	Single Pulse Avalanche Energy®	96	mJ
I <sub>AR</sub>	Avalanche Current®	-7.2	Α
EAR	Repetitive Avalanche Energy®	4.5	m J
dv/dt	Peak Diode Recovery dv/dt ③	-5.0	V/ns
Tu	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	
		the state of the s	

#### Thermal Resistance

	Parameter	Typ.	Max.	Units	
Rejo	Junction-to-Case		3.3	3 17-11	
R <sub>ecs</sub>	Case-to-Sink, Flat, Greased Surface	0.50		°C/W	
R <sub>BJA</sub>	Junction-to-Ambient	_	62		

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### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-55	-	-	V	$V_{GS} = 0V$ , $I_{D} = -250\mu A$
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	-	-0.05	<u></u>	V/°C	Reference to 25°C, ID = -1mA
R <sub>DS(an)</sub>	Static Drain-to-Source On-Resistance	-	_	0.175	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -7.2A ④
VGS(th)	Gate Threshold Voltage	-2.0	-	-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
g <sub>fs</sub>	Forward Transconductance	2.5	-	-	S	$V_{DS} = -25V$ , $I_D = -7.2A$
0	Projects Source Lackage Coment	-1-		-25	А	$V_{DS} = -55V, V_{GS} = 0V$
DSS	Drain-to-Source Leakage Current		$\longrightarrow$	-250	μА	$V_{DS} = -44V$ , $V_{GS} = 0V$ , $T_{J} = 150$ °C
D	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
GSS	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V
Qg	Total Gate Charge		<del></del>	19	77	I <sub>D</sub> = -7.2A
Qgs	Gate-to-Source Charge	-	=	5.1	nC	V <sub>DS</sub> = -44V V <sub>GS</sub> = -10V, See Fig. 6 and 13 ④
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		_	10		
t <sub>d(on)</sub>	Turn-On Delay Time	-	13	-		V <sub>DD</sub> = -28V
tr	Rise Time	_	55			$I_D$ = -7.2A $R_G$ = 24 $\Omega$ $R_D$ = 3.7 $\Omega$ , See Fig. 10 ③
td(off)	Turn-Off Delay Time		23		ns	
t <sub>f</sub>	Fall Time	-	37	-		
L <sub>D</sub>	Internal Drain Inductance		4.5		a Li	Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance	-	7.5	=	nН	from package and center of die contact
Ciss	Input Capacitance	j	350			V <sub>GS</sub> = 0V
Coss	Output Capacitance		170	,—.	pF	V <sub>DS</sub> = -25V
Crss	Reverse Transfer Capacitance	-	92			f = 1.0MHz, See Fig. 5

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур,	Max.	Units	Conditions	
ls	Continuous Source Current (Body Diode)	1	24	-12	Α	MOSFET symbol showing the	
Ism	Pulsed Source Current (Body Diode) ①		-	-48		integral reverse p-n junction diode,	
V <sub>SD</sub>	Diode Forward Voltage		نيت	-1.6	V	TJ = 25°C, IS = -7.2A, VGS = 0V @	
trr	Reverse Recovery Time		47	71	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = -7.2A	
Qrr	Reverse RecoveryCharge		84	130	μC	di/dt = -100A/µs ④	
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub>					

#### Notes:

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- ① Repetitive rating; pulse width limited by max, junction temperature. ( See fig. 11 )
- ② Starting  $T_J$  = 25°C, L = 3.7mH  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = -7.2A. (See Figure 12)
- ③ I<sub>SD</sub>  $\leq$  -7.2A, di/dt  $\leq$  -280A/ $\mu$ s, V<sub>DD</sub>  $\leq$  V<sub>(BR)DSS</sub>, T<sub>J</sub>  $\leq$  175°C
- 9 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .

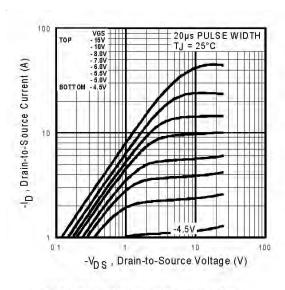
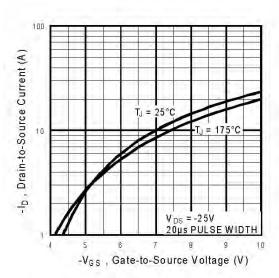


Fig 1. Typical Output Characteristics,

Fig 2. Typical Output Characteristics,



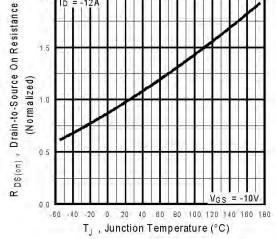


Fig 3. Typical Transfer Characteristics

**Fig 4.** Normalized On-Resistance Vs. Temperature

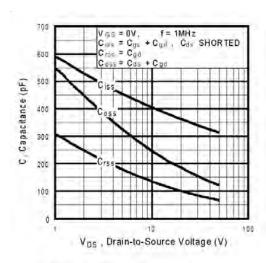


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

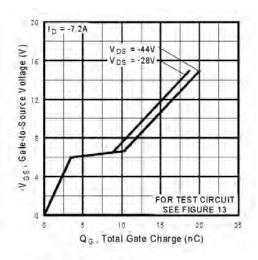


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

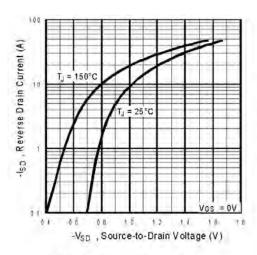


Fig 7. Typical Source-Drain Diode Forward Voltage

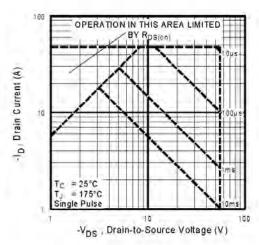


Fig 8. Maximum Safe Operating Area

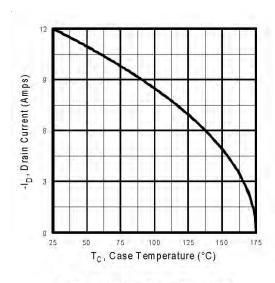


Fig 9. Maximum Drain Current Vs. Case Temperature

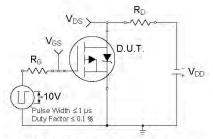


Fig 10a. Switching Time Test Circuit

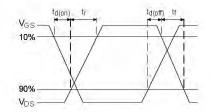


Fig 10b. Switching Time Waveforms

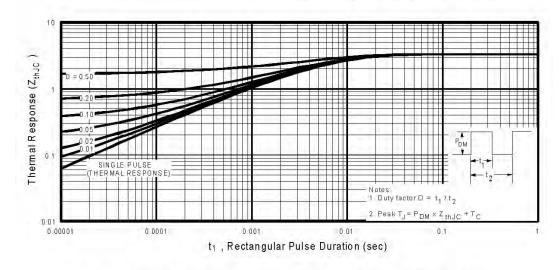


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

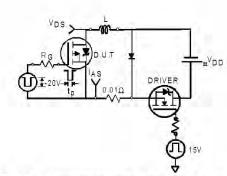


Fig 12a. Unclamped Inductive Test Circuit

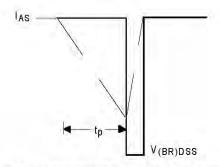


Fig 12b. Unclamped Inductive Waveforms

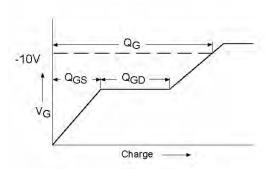


Fig 13a. Basic Gate Charge Waveform

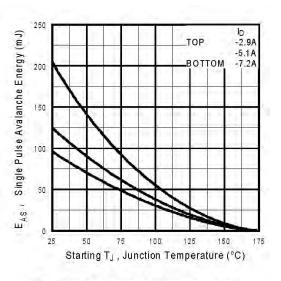


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

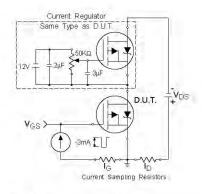
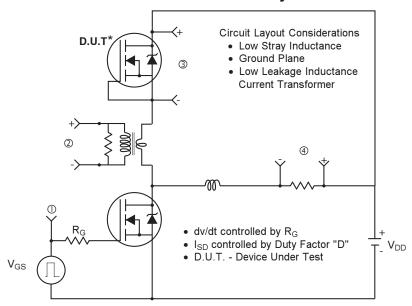
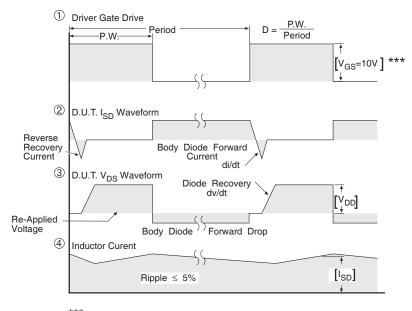


Fig 13b. Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



<sup>\*</sup> Reverse Polarity of D.U.T for P-Channel

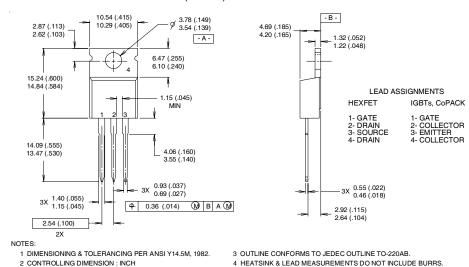


\*\*\*  $V_{GS}$  = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For P-channel HEXFETS

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



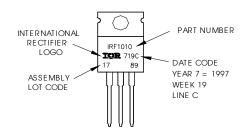
## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free'



Data and specifications subject to change without notice.



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